# **MOSFET** - Power, Single N-Channel, D<sup>2</sup>PAK7

80 V, 1.34 mΩ, 290 A

# **NVBGS1D2N08H**

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualification
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

# MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage		V <sub>DSS</sub>	80	V	
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Current R <sub>θJC</sub> (Note 2)	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	290	Α
		T <sub>C</sub> = 100°C		205	
Power Dissipation		T <sub>C</sub> = 25°C	P <sub>D</sub>	259	W
R <sub>θJC</sub> (Note 2)		T <sub>C</sub> = 100°C		130	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	43	A
Current R <sub>θJA</sub> (Notes 1, 2)	Steady	T <sub>A</sub> = 100°C		31	11.
Power Dissipation	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	5.7	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C	RE	2.9	. 6
Pulsed Drain Current	$T_A = 25^\circ$	C, t <sub>p</sub> = 100 μs	I <sub>DM</sub>	900	A
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	55 to +175	ç	
Source Current (Body Diode)		ls'	199	Α	
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L</sub> = 32 A <sub>pk</sub> )		E <sub>AS</sub>	1500	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{\theta JC}$	0.58	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	26.2	

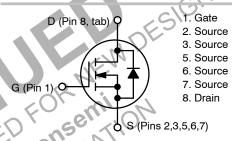
- 1. Surface-mounted on FR4 board using a 1 in<sup>2</sup> pad size, 2 oz. Cu pad.
- 2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.



# ON Semiconductor®

www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
80 V	1.34 m $\Omega$ @ 10 V	290 A



N-CHANNEL MOSFET





BGS1D2N08H = Specific Device Code

= Assembly Location

= Year = Work Week WW = Pb-Free Package

#### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NVBGS1D2N08H	D <sup>2</sup> PAK7 (Pb-Free)	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /	I <sub>D</sub> = 250 μA, ref to 25°C			56		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$I_{DSS}$ $V_{GS} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$				10	μΑ
		V <sub>DS</sub> = 80 V	T <sub>J</sub> = 125°C			250	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±20 V				±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 650 μΑ	2.0	2.9	4.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = 650 μA, ref to 25°C			-7.5		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 50 A			1.1	1.34	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 50 A			213	(3)	S
Gate-Resistance	$R_{G}$				0.5	0	Ω
CHARGES, CAPACITANCES & GATE RES	ISTANCE				Or		
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V, f = 1 MHz		IEV	10830		pF
Output Capacitance	C <sub>OSS</sub>		00	14,	1605		
Reverse Transfer Capacitance	C <sub>RSS</sub>		50r	in.	45		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 40 V; I <sub>D</sub> = 50 A		S, </td <td>160</td> <td></td> <td>nC</td>	160		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	101	011	VB,	28		
Gate-to-Source Charge	Q <sub>GS</sub>	V <sub>qs</sub> = 10 V, V <sub>Ds</sub> = 40 V; I <sub>D</sub> = 50 A		,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	43		
Gate-to-Drain Charge	Q <sub>GD</sub>				33		
Plateau Voltage	V <sub>GP</sub>				4.3		V
SWITCHING CHARACTERISTICS	,21	14K 50,					
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 64 \text{ V}, \\ I_{D} = 50 \text{ A}, R_{G} = 6 \Omega$			40		ns
Rise Time	Ct <sub>r</sub>				34		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	,			134		
Fall Time	CH				45		
DRAIN-SOURCE DIODE CHARACTERIST	ics			<u>-</u>			
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V$	T <sub>J</sub> = 25°C		0.8	1.3	V
THIS KI		I <sub>S</sub> = 50 A	T <sub>J</sub> = 125°C		0.65		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dl}_S/\text{dt} = 100 \text{ A}/\mu\text{s,}$ $I_S = 50 \text{ A}$			78		ns
Reverse Recovery Charge	$Q_{RR}$				122		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: pulse width  $\leq 300 \, \mu s$ , duty cycle  $\leq 2\%$ .

#### **TYPICAL CHARACTERISTICS**

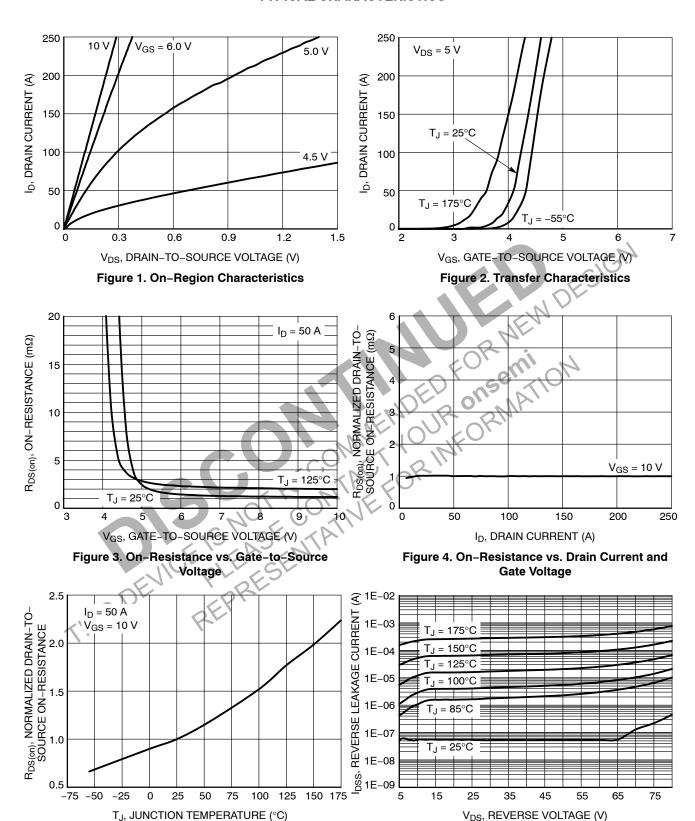


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

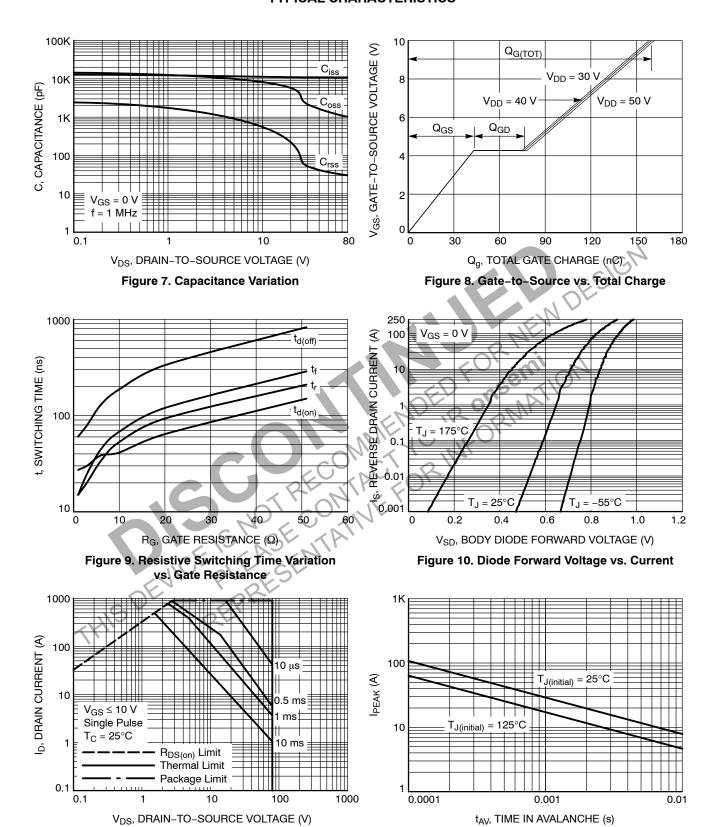
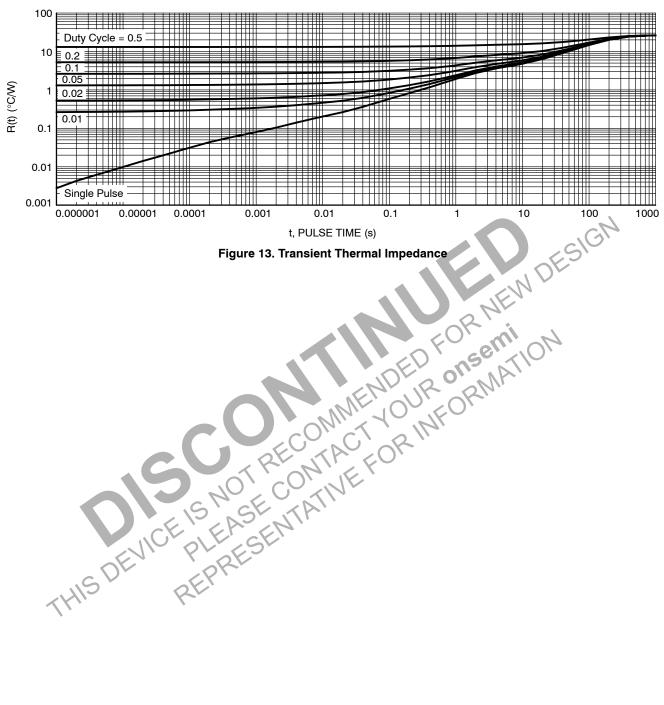


Figure 11. Maximum Rated Forward Biased
Safe Operating Area

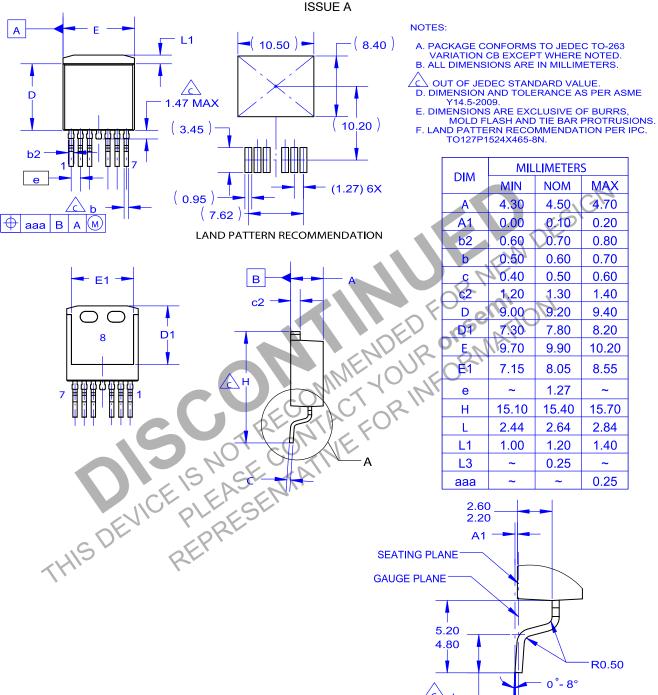
Figure 12. Maximum Drain Current vs. Time in Avalanche

#### TYPICAL CHARACTERISTICS



#### PACKAGE DIMENSIONS

# **D2PAK7 (TO-263-7LD) 15.4x9.9x4.5** CASE 221BP



L3

DETAIL A SCALE 2:1



onsemi, ONSEMI., and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="https://www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human

#### ADDITIONAL INFORMATION

**TECHNICAL PUBLICATIONS:** 

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$ 

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales